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INFO	RMATION I	חופריו	Adilon	Application Number	740819-1016 0/600,596	
	•			Filing Date	June 23, 2003	
STATEMENT BY APPLICANT				First Named Inventor	Satoshi SHIBATA et al.	
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				Examiner Name	S. Pruchnic	
Sheet	1	ọf	1	Attorney Docket Number	740819-1016	

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. 1	U.S. Patent Document Number - Kind Code* (if known).	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
<i>500</i>		US-6,132,081	10/17/2000	Han	-7.
-		US-6,022,749	02/08/2000	Davis et al.	- /-
		US-5,902,504	05/11/1999	Merchant et al.	~ / \
		US-5,265,957	11/30/1993	Moslehi et al.	- /
		US-6,299,346 B1	10/09/2001	Ish-Shalom et al.	- /.
		US-6,475,815 B1	11/05/2002	Nambu et al.	_ / ~
		US-6,472,232 B1	10/29/2002	Johnson et al.	. / -
		US-6,200,023 B1	03/13/2001	Tay et al.	1-/-
		US-6,128,084	10/03/2000	Nanbu et al.	- /.~
		US-6,126,744	10/03/2000	Hawkins et al.	-1-
		US-5,994,676	11/30/1999	Dutartre	-/
V .		US-5,769,540	06/23/1998	Schietinger et al.	- / -
500	T	US-4,786,608	11/22/1998	Griffith	1-/-

		F	OREIGN PATENT D	OCUMENTS			
Examiner Initials	Cite No.1	Foreign Patent Document Kind Code' Country Code' Number' (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Т4	
561		WO 98/57146 A1	12/17/1998		-/-	Abstract	
		OTHER PRIOR	ART – NON PATENT I	LITERATURE DOCUMENTS			
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.)., date, page(s), volume-issue number(s), publisher, city and/or country where published.					
568		Fried, M., et al., "Optical properties of thermally stabilized ion implantation amorphized silicon," Nuclear Instruments and Methods in Physics Research, B19/20, North-Holland, Amsterdam (1987) 577-581.					
Ø\$		Csepregi, L., et al., "Reord and 11B ions," Journal of					

Examiner			Date	2/2/1
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Signature	1 - May Style ,	T RUCKNI	Considered	2/0/01
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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